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Applicati n/Control N .	Applicant(s)/Patent under Reexamination	
10/605,585	TAKAOKA ET AL.	
Examiner	Art Unit	
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SEARCHED					
Class	Subclass	Date	Examiner		
257	276,502 621	1/21/2005	O.N.		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search, JPO, EPO, Derwent, IBM< PGPub	1/21/2005	O.N.	